

SSC8L42PN6

N-Channel Enhancement Mode MOSFET

Features

V _{DS}	V _{GS}	R _{DS(ON)} Typ.	l _D
40V	+20V	1.0 mΩ@10V	1504
400	<u> </u>	1.5 mΩ@4.5V	150A

> Description

This device is N-Channel enhancement MOSFET.

Uses SGT technology and design to provide excellent

RDSON with low gate charge. This device is suitable
for use in DC-DC conversion, power switch and
charging circuit.

100% UIS + ΔVDS + Rg Tested!

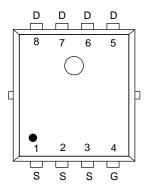
Applications

- DC/DC converters
- Power supplies
- Motor Drive Control
- Synchronous rectification

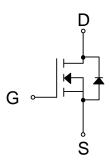
Ordering Information

Device	Package	Shipping
SSC8L42PN6	PDFN5X6-8L	5000/Reel

> Pin Configuration



PDFN5X6-8L(Top View)



Pin Configuration



Marking

(XXYY: Internal Traceability Code)



➤ Absolute Maximum Ratings (T_A=25°C unless otherwise noted)

Symbol	Parameter	Ratings	Unit	
V _{DSS}	Drain-to-Source Voltage		40	V
V _{GSS}	Gate-to-Source Voltaç			V
V _{GSS} Gate-to-Source Voltage I _D Continuous Drain Current ^d I _{DSM} Continuous Drain Current ^a I _{DM} Pulsed Drain Current ^b P _D Power Dissipation ^c	T _C =25°C	150	Δ.	
ID	Continuous Drain Current	T _C =100°C	95	A
	Continuous Drain Current ^a	T _A =25°C	46	Δ.
IDSM		T _A =70°C	34	Α
I _{DM}	Pulsed Drain Current	Pulsed Drain Current ^b		Α
	5 5	Tc=25℃	78	34/
Pb	Power Dissipation •	T _C =100°C	32	W
D.	Barras Biratian a	T _A =25°C	7.0	10/
P _{DSM}	Power Dissipation ^a	T _A =70°C	4.5	W
las	Avalanche Current ^b L=0.5mH Single Pulse		42	Α
Eas	Avalanche Energy ^b L=0.5mH Single Pulse		441	mJ
TJ	Operation junction temperature		-55~150	°C
T _{STG}	Storage temperature range		-55~150	℃

➤ Thermal Resistance Ratings (T_A=25°C unless otherwise noted)

Symbol	Parameter	Ratings	Unit
RθJA	Junction-to-Ambient Thermal Resistance ^a	17	°C/W
R _{θJC}	Junction-to-Case Thermal Resistance	1.5	C/VV

Note:

- a. The value of R_{θJA} is measured with the device mounted on 1 in² FR-4 board with 2oz.copper, in a still air environment with T_A=25°C. The value in any given application depends on the user is specific board design. The power dissipation is based on the t≤10s thermal resistance rating.
- b. Repetitive rating, pulse width limited by junction temperature.
- c. The power dissipation P_D is based on $T_{J(MAX)}$ =150°C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heat sinking is used.
- d. The maximum current rating is package limited.

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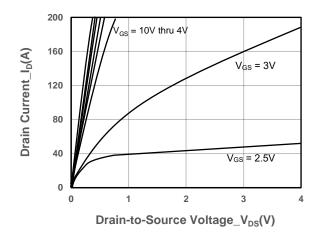


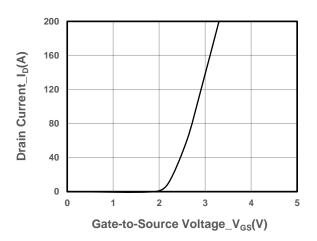
\succ Electrical Characteristics (T_A=25°C unless otherwise noted)

Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit
Drain-Source Breakdown Voltage	V _{(BR)DSS}	V _{GS} = 0V, I _D = 250µA	40			V
Gate Threshold Voltage	$V_{\text{GS(th)}}$	$V_{DS} = V_{GS}$, $I_D = 250uA$	1.0	1.9	2.5	V
Drain-Source On-Resistance	R _{DS(on)}	V _{GS} = 10V, I _D = 20A		1.0	1.24	mΩ
Drain-Source On-Resistance	R _{DS(on)}	V _{GS} = 4.5V, I _D = 20A		1.5	2.1	mΩ
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 40V, V _{GS} = 0V			1	μA
Gate-Source Leak Current	I _{GSS}	V _{GS} = ±20V, V _{DS} = 0V			±100	nA
Transconductance	G _{FS}	V _{DS} = 5V, I _D = 10A		110		S
Forward Voltage	V _{SD}	V _{GS} = 0V, I _S = 20A			1.3	V
Gate Resistance	R _G	V _{DS} = 0V, f = 1MHz		2.3		Ω
Input Capacitance	Ciss	V 00V V 0V		5900		
Output Capacitance	Coss	$V_{DS} = 20V, V_{GS} = 0V,$		2100		pF
Reverse Transfer Capacitance	Crss	f = 1MHz		112		
Total Gate Charge	Q _G	101/1/ 001/		86		
Gate to Source Charge	Q _G s	V _{GS} = 10V, V _{DS} = 20V,		27		nC
Gate to Drain Charge	Q _{GD}	I _D = 50A		9		
Turn-on Delay Time	T _{D(ON)}			23		
Rise Time	Tr	$V_{GS} = 10V, R_L = 0.4\Omega,$		64		
Turn-off Delay Time	T _{D(OFF)}	$V_{DS} = 20V, R_G = 4.7\Omega$		88		ns
Fall Time	T _f			30		
Diode Recovery Time	T _{rr}	I _F =37A, di/dt=100A/us		65		ns
Diode Recovery Charge	Q _{rr}	I _F =37A, di/dt=100A/us		72		nC



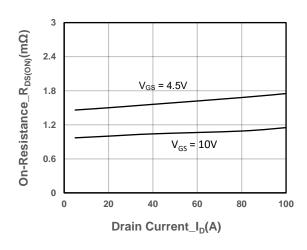
➤ Typical Performance Characteristics (T_A=25°C unless otherwise noted)

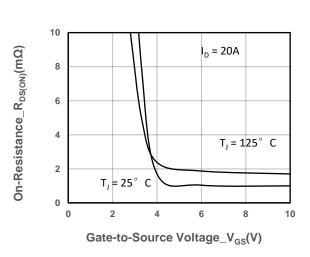




Output Characteristics

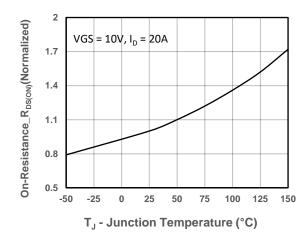
Transfer Characteristics

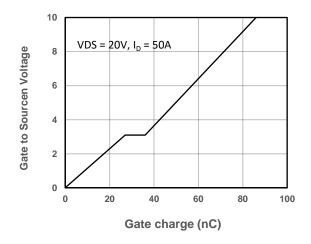




On-Resistance vs. Drain Current and Gate Voltag

On-Resistance vs. Gate-to-Source Voltage

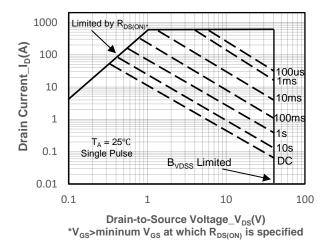




On-Resistance vs. Junction Temperature

Gate-Source Voltage vs. Gate charge

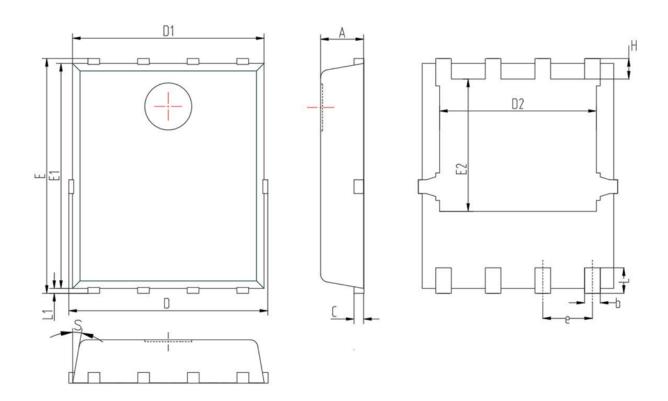




Safe Operating Area vs. Junction-to-Ambient



> Package Information



Cumbal	MILL IMETER			
Symbol	Min	Nom	Max	
А	0.90	1.05	1.20	
b	0.25	0.30	0.51	
С	0.15	0.25	0.35	
D	4.80	5.10	5.40	
D1	4.80	5.00	5.20	
D2	3.70	4.00	4.30	
E	5.80	6.15	6.50	
E1	5.50	5.75	5.95	
E2	3.30	3.45	3.67	
е	1.27BSC			
Н	0.40	0.60	0.93	
L	0.45	0.65	0.85	
L1	0.00	0.10	0.25	
S	0°		12°	



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